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APPLICATION NO.	FILING DATE		FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO	
10/612,607	07/01/2003		Yun-Sheng Chen	JCLA10931 4794		
7590 03/29/2004		03/29/2004		EXAM	EXAMINER	
J.C. Patents, Inc. Suite 250				SOWARD	SOWARD, IDA M	
4 Venture				ART UNIT	PAPER NUMBER	
Irvine, CA 9	2618			2822		
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DATE MAILED: 03/29/2004

Please find below and/or attached an Office communication concerning this application or proceeding.

		Applicat	ion No	Applicant(s)				
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Office Action Summary		10/612,6		CHEN, YUN-SHEN				
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THE MAIL - Extensions after SIX (6) - If the period - If NO period - Failure to re Any reply re	ENED STATUTORY PERIOD F. ING DATE OF THIS COMMUNI of time may be available under the provisions) MONTHS from the mailing date of this comm for reply specified above is less than thirty (3 d for reply is specified above, the maximum sta- eply within the set or extended period for reply secreted by the Office later than three months a ent term adjustment. See 37 CFR 1.704(b).	ICATION. of 37 CFR 1.136(a). In no enunication. 0) days, a reply within the structury period will apply and will, by statute, cause the ap	vent, however, may a reply be til atutory minimum of thirty (30) day will expire SIX (6) MONTHS from plication to become ABANDONE	nely filed ys will be considered timely the mailing date of this co ED (35 U.S.C. § 133).				
Status	*				,			
1)⊠ Res	ponsive to communication(s) file	ed on .						
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3)☐ Sinc	Since this application is in condition for allowance except for formal matters, prosecution as to the merits is closed in accordance with the practice under <i>Ex parte Quayle</i> , 1935 C.D. 11, 453 O.G. 213.							
Disposition o	f Claims							
4a) 0 5)⊡ Clai 6)⊠ Clai 7)⊡ Clai	Claim(s) 1-10 is/are pending in the application. 4a) Of the above claim(s) 1-8 is/are withdrawn from consideration. Claim(s) is/are allowed. Claim(s) 9 and 10 is/are rejected. Claim(s) is/are objected to. Claim(s) are subject to restriction and/or election requirement.							
Application P	apers							
10)□ The Appl Repl	specification is objected to by the drawing(s) filed on is/are: icant may not request that any objected to accement drawing sheet(s) including oath or declaration is objected to	: a) ☐ accepted or b ction to the drawing(s) the correction is requ	be held in abeyance. Se ired if the drawing(s) is ob	e 37 CFR 1.85(a). ojected to. See 37 CF				
Priority unde	r 35 U.S.C. § 119							
 12) Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f). a) All b) Some * c) None of: 1. Certified copies of the priority documents have been received. 2. Certified copies of the priority documents have been received in Application No 3. Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)). * See the attached detailed Office action for a list of the certified copies not received. 								
2) Notice of D	teferences Cited (PTO-892) traftsperson's Patent Drawing Review (P		4) Interview Summary Paper No(s)/Mail D	ate				
3) Information	n Disclosure Statement(s) (PTO-1449 or s)/Mail Date		5) Notice of Informal I 6) Other:	Patent Application (PTC) - 152)			

Art Unit: 2822

DETAILED ACTION

This Office Action is in response to the election filed February 27, 2004.

Election/Restrictions

Applicant's election without traverse of Group I, claims 9-10 in Paper No. 02-27-03 is acknowledged.

Priority

Receipt is acknowledged of papers submitted under 35 U.S.C. 119(a)-(d), which papers have been placed of record in the file.

Claim Rejections - 35 USC § 112

The following is a quotation of the second paragraph of 35 U.S.C. 112:

The specification shall conclude with one or more claims particularly pointing out and distinctly claiming the subject matter which the applicant regards as his invention.

Claim 2 recites the limitation "the amorphous silicon layer" on page 11, lines 21-22. There is insufficient antecedent basis for this limitation in the claim.

Claim Rejections - 35 USC § 103

The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and

Art Unit: 2822

the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.

Claims 9-10 are rejected under 35 U.S.C. 103(a) as being unpatentable over Hamada (5,888,856) in view of Miyasaka (6,124,154).

In regard to claim 9, Hamada teaches a low temperature poly-silicon thin film transistor (LTPS TFT), comprising: a poly-silicon layer 102, deposited on a substrate 101, and the poly-silicon layer comprises a source, a drain, and a channel that is deposited in between the source and the drain, a gate isolation layer, 103 deposited on the substrate, and covering the poly-silicon layer; a gate 104, correspondingly deposited on the gate isolation layer that is deposited above the channel; a dielectric layer 105, deposited on the gate isolation layer, and covering the gate; a source metal layer 106, deposited on a surface of the dielectric layer and in the dielectric layer and the gate isolation layer wherein the source metal layer is electrically connected to the source; and a drain metal layer 106, deposited on the surface of the dielectric layer and in the dielectric layer and the gate isolation layer wherein the drain metal layer is electrically connected to the drain (Figure 1, cols. 2-3, lines 50-67 and 1-55, respectively).

As best understood and in regard to claim 10, Hamada teaches a buffer layer 2 in between the substrate 1 and the amorphous layer 3a (Figures 4I-4J, cols. 3-5, lines 56-67, 1-67 and 1-25, respectively).

However, Hamada fails to teach a height/width ratio of a plurality of mounds on a surface of the poly-silicon layer is less than 0.2. In the specification of the claimed invention, having a height/width ratio of a plurality of mounds on a surface of the poly-silicon layer being less than 0.2 is not shown as being critical. Miyasaka teaches a

Art Unit: 2822

laser anneal treatment of a poly-silicon layer which improves film surface (cols. 16-17, lines 40-67 and 1-7, respectively).

Since Hamada and Miyasaka are from the same field of endeavor (low temperature poly-silicon thin film transistors), the purpose disclosed by Miyasaka would have been pertinent in the art of Hamada. Therefore, it would have been obvious to one having ordinary skill in the art at the time the invention was made to modify the low temperature poly-silicon thin film transistor as taught by Hamada with the low temperature poly-silicon thin film transistor having laser anneal treatment of the poly-silicon layer as taught by Miyasaka to provide high yield, high reliability thin film transistors (col. 3, lines 19-30).

Conclusion

The prior art made of record and not relied upon is considered pertinent to applicant's disclosure.

The following patents are cited to further show the state of the art with respect to low temperature poly-silicon thin film transistors (LTPS TFTs):

Kubota et al. (US 6,300,927 B1)

Matsueda (US 6,281,700 B1)

Ohtani et al. (6,011,275)

Yamazaki (US 6,207,969 B1).

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Ida M Soward whose telephone number is 571-272-

Art Unit: 2822

1845. The examiner can normally be reached on Monday - Thursday, 6:30 am to 5:00 pm.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Amir Zarabian can be reached on 571-272-1852. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

IMS March 18, 2004

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Page 5